

# Fake Ratios for a Same-Sign Double Lepton SUSY Search

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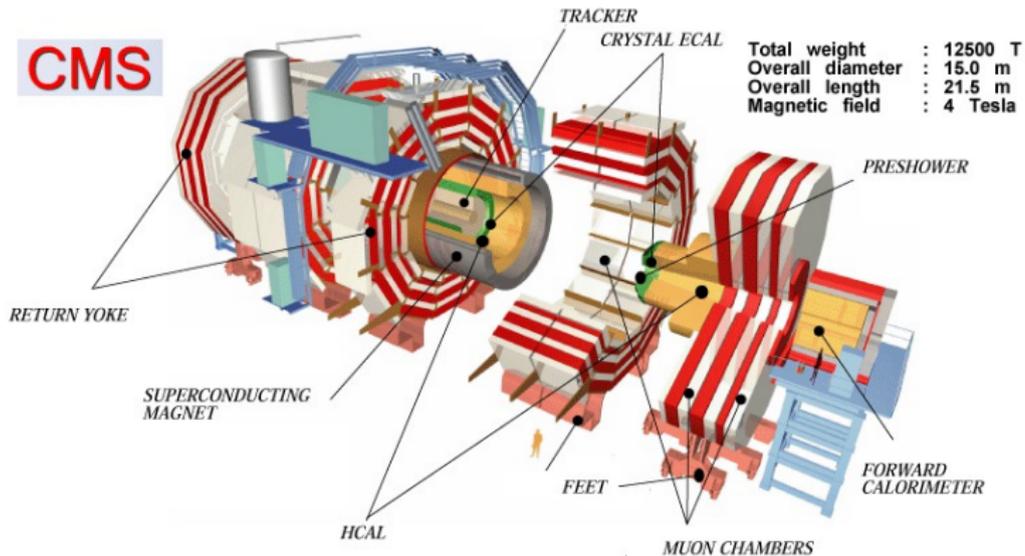
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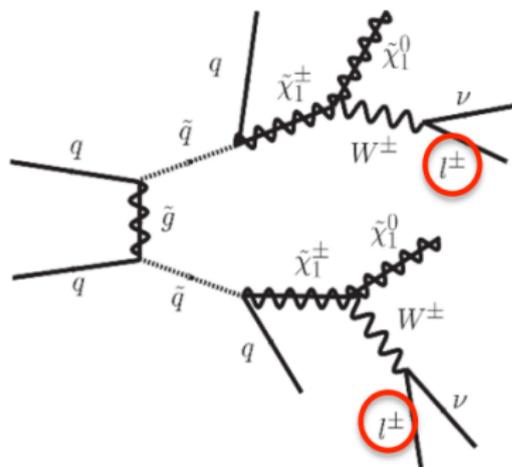
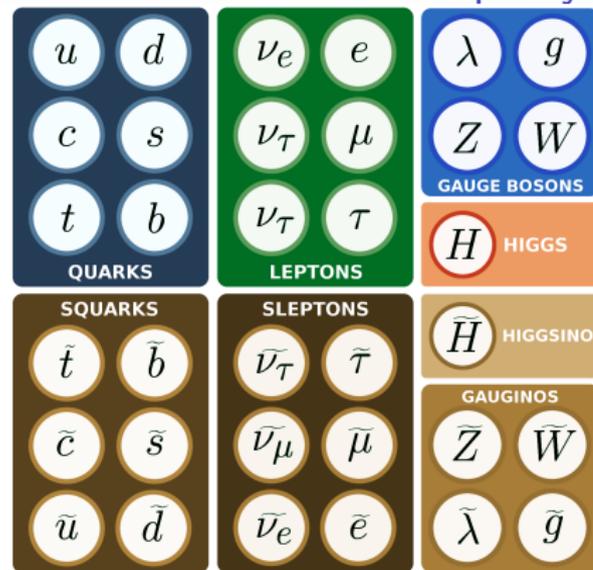
# Outline

- Introduction to CMS and SUSY
- Selection
- Validation Plots
- Methodology of Fake Rate Measurements
- Results

# CMS - Compact Muon Solenoid



## Supersymmetry

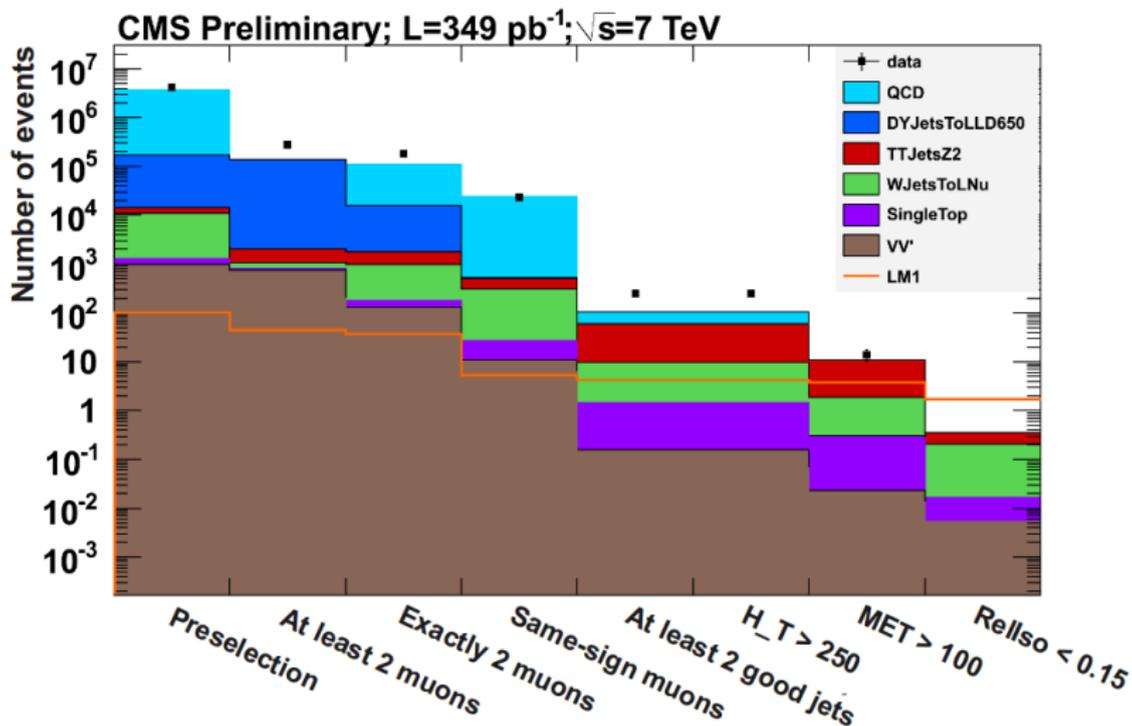


- Symmetry between fermions and bosons
- Each SM particle has superpartner with spin that differs by  $\frac{1}{2}$
- R-parity is conserved  $R = (-1)^{3(B-L)+2S}$
- Lightest SUSY particle (LSP) is stable  $\rightarrow$  Missing  $E_T$  (MET)

# Event Selection

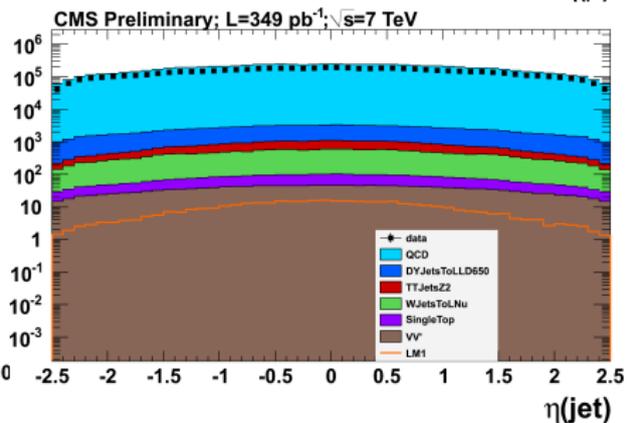
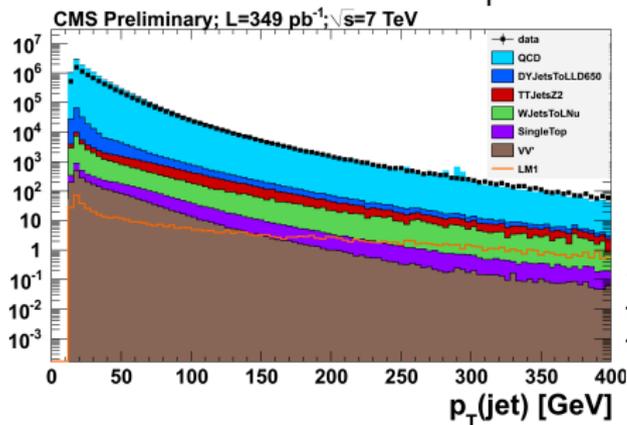
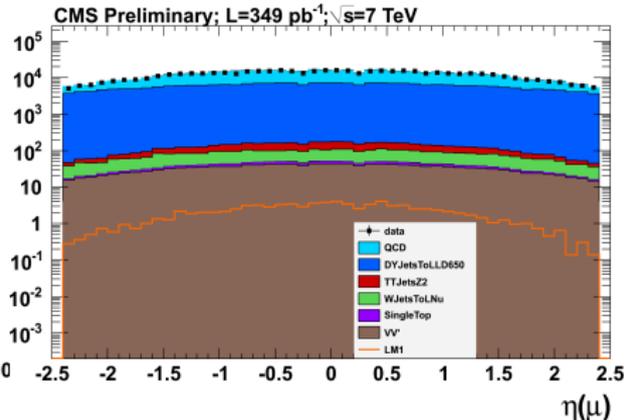
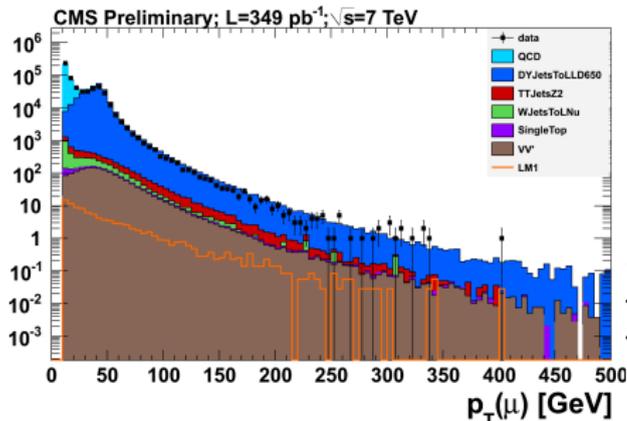
- Bunches of protons collide up to 40 million times per second
- Trigger system selects potentially interesting events only
- Amount of data that must be analysed is still huge
- Aim: Filter out SS (same-sign) dilepton events
- SUSY selection
  - Exactly 2 SS leptons
  - $MET > 100 \text{ GeV}$  ( $MET = |\sum_i \vec{p}_{T,i}|$ ) (because LSP leaves undetected)
  - $H_T > 250 \text{ GeV}$  ( $H_T = \sum |\vec{j}et_{p_T}|$ )
- From 1 million events we select  $\sim 1$

## Event selection

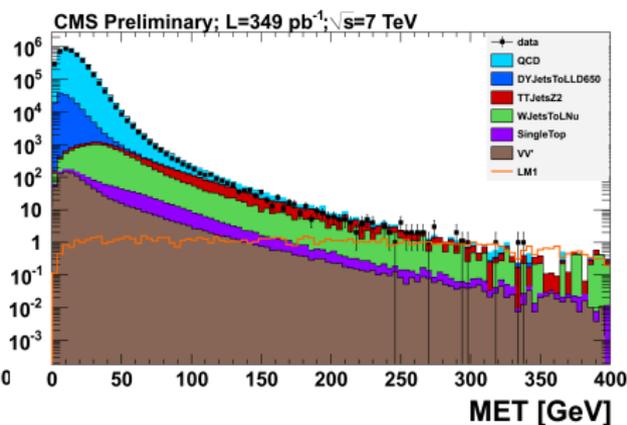
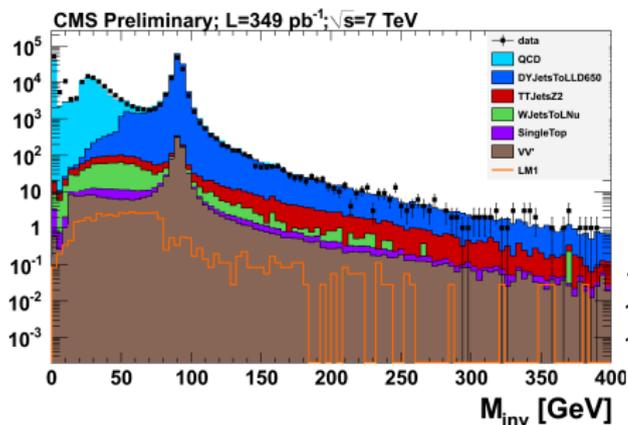


After the SUSY selection, a SUSY scenario (orange line) and SM are well separated

# Validation plots



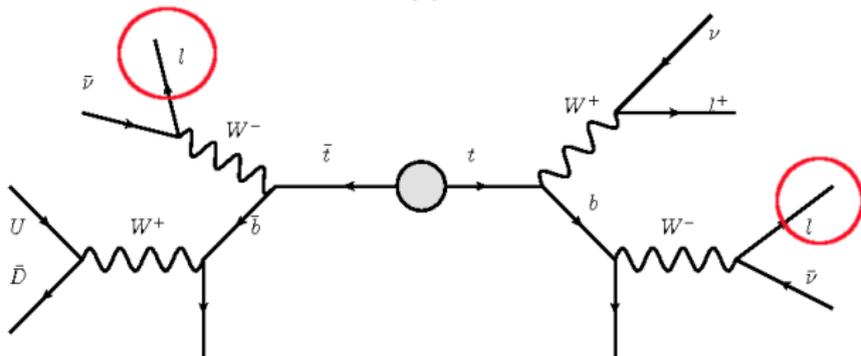
# Validation plots



$$M_{inv}(\mu_1\mu_2) = \sqrt{E^2 - \|\vec{p}_{\mu_1\mu_2}\|^2}$$

$$p_{\mu_1\mu_2} = p_{\mu_1} + p_{\mu_2}$$

## Background



- Fake leptons
  - heavy flavour decay (diagram)
  - leptons from  $\gamma$  conversions
  - jets taken as leptons
- Prompt leptons - from  $W$  decay in  $t\bar{t}$  (diagram) or from  $SS$  chargino decay in SUSY
  - There is no  $SS$  prompt di-lepton production in SM
- Isolated  $SS$  dileptons are very rare in SM but
  - $t\bar{t}$  and  $W$  + jets - one fake and one prompt lepton
  - QCD - both leptons are fake
- Estimate background by extrapolating relative isolation

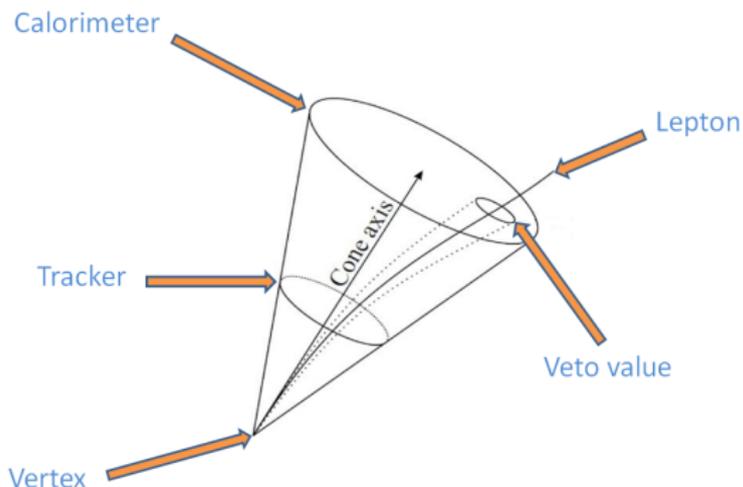
# Relative Isolation

Definition:

$$R_{\text{ellso}} = (Track_{\text{lso}} + E_{\text{callso}} + H_{\text{callso}}) / p_{\text{T}}$$

Loose:  $R_{\text{ellso}} < 1.0$

Tight:  $R_{\text{ellso}} < 0.15$



## Methodology - Tight-to-Loose-Method

- Two samples are defined, regarding isolation criteria:
  - Loose leptons - leptons with  $RelIso < 1$
  - Tight leptons - leptons with  $RelIso < 0.15$  (all tight leptons are also loose)
- ASSUMPTION: a prompt lepton that is loose, has a probability  $p$  of also being tight
- ASSUMPTION: a fake lepton that is loose, has a probability  $f$  of also being tight
- The number of events with one tight lepton and one loose lepton will follow from  $N_{pp}$ ,  $N_{pf}$  and  $N_{ff}$  using simple combinatorics

$$N_{t10} = 2p(1 - p)N_{pp} + [p(1 - f) + f(1 - p)]N_{fp} + 2f(1 - f)N_{ff}$$

## Relations

In general, the number of events with all the possibilities for the leptons passing/failing the tight criteria can be derived in terms of the different contributions  $N_{pp}$ ,  $N_{pf}$  and  $N_{ff}$  via  $A$

$$\begin{pmatrix} N_{pp} \\ N_{pf} \\ N_{fp} \\ N_{ff} \end{pmatrix} = A(p, f) \begin{pmatrix} N_{t00} \\ N_{t01} \\ N_{t10} \\ N_{t11} \end{pmatrix}$$

### Main idea behind this method:

By measuring  $\mathbf{p}$  and  $\mathbf{f}$  in control regions and then  $N_{t00}$ ,  $N_{t01}$ ,  $N_{t10}$ ,  $N_{t00}$  with the SUSY selection, we can easily invert the previous relation and obtain an estimation of  $N_{pf}$  and  $N_{ff}$ , which are the backgrounds, as well as  $N_{pp}$ , which is the signal

The prompt and fake ratios are measured in different  $p_T$  bins. The algebra is a bit more complicated, but conceptually it is the same idea.

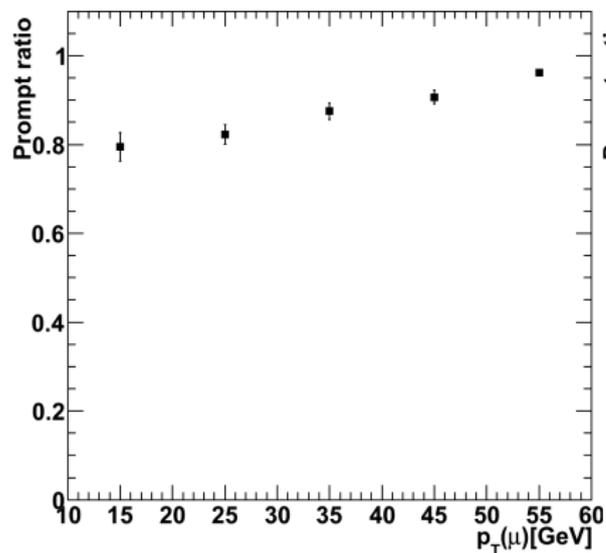
Algebra:

$$A = \begin{pmatrix} f_1 f_2 & -(1 - f_1) f_2 & -f_1 (1 - f_2) & (1 - f_1) (1 - f_2) \\ -f_1 p_2 & (1 - f_1) p_2 & f_1 (1 - p_2) & -(1 - f_1) (1 - p_2) \\ -p_1 f_2 & (1 - p_1) f_2 & p_1 (1 - f_2) & -(1 - p_1) (1 - f_2) \\ p_1 p_2 & -(1 - p_1) p_2 & -p_1 (1 - p_2) & (1 - p_1) (1 - p_2) \end{pmatrix}$$

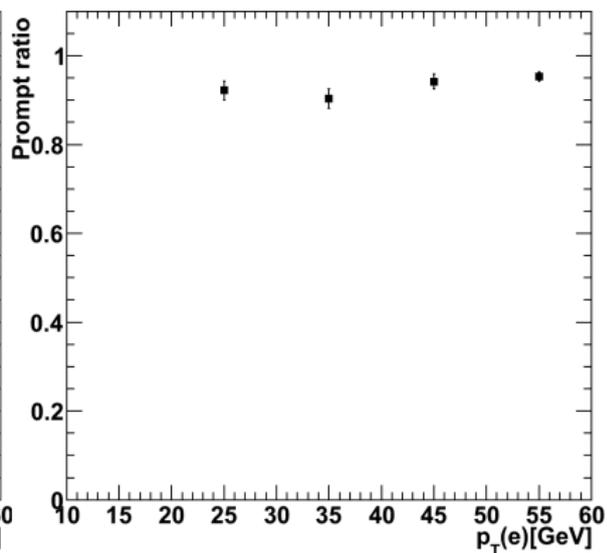
$$\begin{pmatrix} N_{pp} \\ N_{pf} \\ N_{fp} \\ N_{ff} \end{pmatrix} = \frac{A}{(p_1 - f_1)(p_2 - f_2)} \begin{pmatrix} N_{t00} \\ N_{t01} \\ N_{t10} \\ N_{t11} \end{pmatrix}$$

sum over all bins  $\Rightarrow N_{xy} = \sum_{p_{T1}, \eta_1, p_{T2}, \eta_2}$ ,  $x, y = p, f$

# Prompt Ratio for Muons & Electrons

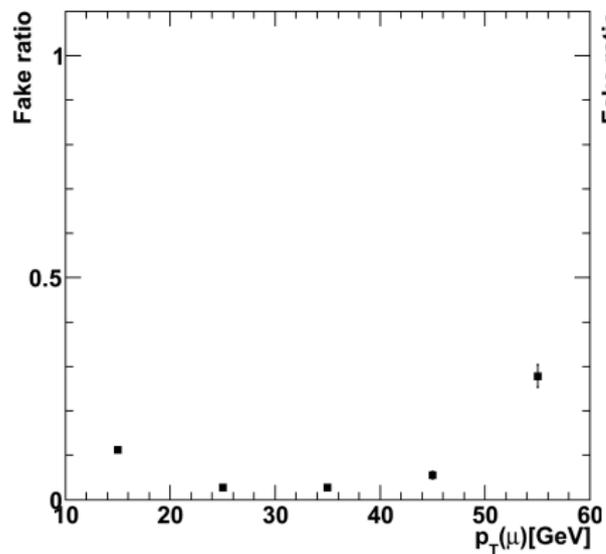


Prompt ratio for muons

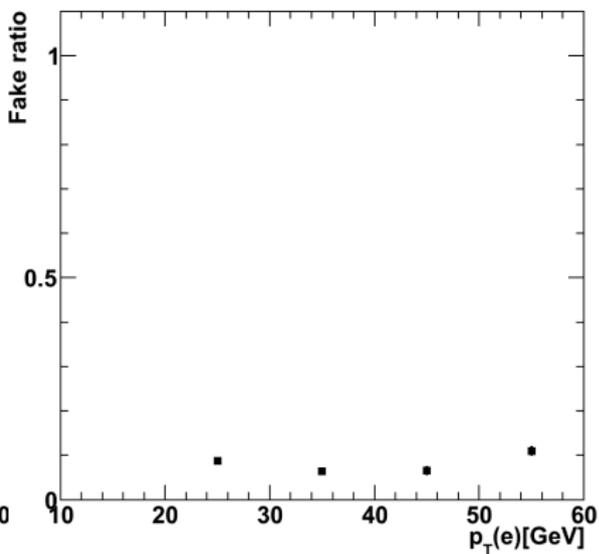


Prompt ratio for electrons

# Fake Ratio for Muons & Electrons



Fake ratio for muons



Fake ratio for electrons

# Results - Event Yield after SUSY Selection

*Counting over Data*  
 $(N_{t00}, N_{t10}, N_{t01}, N_{t11}) \rightarrow \text{Prediction}$

	$\mu\mu$	$e\mu$	ee	total
MC	$0.95 \pm 0.37$	$1.07 \pm 0.33$	$0.32 \pm 0.13$	$2.34 \pm 0.5$
Pred. (TL)	$1.94 \pm 0.57$	$1.4 \pm 0.42$	$0.39 \pm 0.19$	$3.73 \pm 0.73$
Data (1.1fb)	$1 \pm 1$	$2 \pm 1.4$	0	$3 \pm 1.7$
Signal (LM1)	$13.4 \pm 1.3$	$18.3 \pm 1.7$	$5.6 \pm 0.9$	$37.3 \pm 2.3$

# Summary

- SUSY Cut Flow for discovery established (leptonic channel)
- Validation of MC successful
- Background estimation established (Tight-to-Loose method)
- Prompt/ fake ratios for  $e/\mu$  binned in  $p_T$
- No excess found in data yet ( $1.1 \frac{1}{fb}$ )
- Looking forward to more data  $\rightarrow$  exciting times! :-)

Thank you for your  
attention!

# Backup

## Relative isolation

### Muon selection:

$$Rellso = (Tracklso + Ecallso + Hcallso)/p_T$$

Loose:  $Rellso < 1.0$

Tight:  $Rellso < 0.15$

### Electron selection:

$$Rellso = (Tracklso + \max(0., Ecallso - 1) + Hcallso)/p_T \text{ (Barrel)}$$

$$Rellso = (Tracklso + Ecallso + Hcallso)/p_T \text{ (Endcap)}$$

Loose:  $Rellso < 1.0$  (Barrel),  $Reliso < 0.6$  (Endcap)

**Identification:** El.ID cuts defined in the "90% efficiency working point"(WP90)

Tight:  $Rellso < 0.15$

**Identification:** El.ID cuts defined in the "80% efficiency working point"(WP80)

## Methodology - single lepton events

- Assumption: fake ratios are universal and can be applied to other backgrounds
  - $p$  - prompt ratio; probability that a prompt loose lepton is also tight ( $\approx 1$ )
  - $f$  - fake ratio; probability that a fake loose lepton is also tight ( $\approx 0$ )
  - $N_l$  - total number of leptons passing loose criteria
  - $N_p$  - number of prompt leptons
  - $N_f$  - number of fake leptons
  - $N_{t0}$  - number of events where no lepton passes tight criteria
  - $N_{t1}$  - number of events where one lepton passes tight criteria
- $N_p$  and  $N_f$  not directly measurable; related to  $N_{t0}$  and  $N_{t1}$

## Methodology - single lepton events

$$\left. \begin{array}{l} N_x, x = p, f \\ N_{tx}, x = 0, 1 \\ p \\ f \end{array} \right\} \rightarrow \text{Depend on } \eta, p_T!$$

$$N_l = N_p + N_f = N_{t0} + N_{t1}$$

Relations:

$$\begin{aligned} N_{t0} &= (1-p)N_p + (1-f)N_f \\ N_{t1} &= pN_p + fN_f \end{aligned} \Rightarrow \begin{aligned} N_p &= \frac{1}{p-f} [(1-f)N_{t1} - fN_{t0}] \\ N_f &= \frac{1}{p-f} [pN_{t0} - (1-p)N_{t1}] \end{aligned}$$

Background estimation:

$$N_{\text{signal}} = N_p^{\text{pass}} = pN_p - \text{Prompt signal}$$

$$N_{\text{contam}} = N_f^{\text{pass}} = fN_f - \text{Fakes passing tight cuts}$$

## Methodology - dilepton events

- Notation:  $N_{xy, x, y = p, f}$  where first label refers to lepton with higher  $p_T$
- $N_{pp}$  - number of events with both prompt leptons
- $N_{pf}$  - number of events with one prompt and one fake lepton
- $N_{ff}$  - number of events with both fake leptons
- $N_{txy}$  ( $x, y = 0, 1$ ) - number of events with 0, 1, or 2 leptons passing tight cuts
- Functions of lepton kinematics

$$\left. \begin{array}{l} N_{xy}, x, y = p, f \\ N_{txy}, x, y = 0, 1 \\ p_{xy}, x, y = l_1, l_2 \\ f_{xy}, x, y = l_1, l_2 \end{array} \right\} \rightarrow \text{Depend on: } p_{T1}, p_{T2}, \eta_1, \eta_2$$

## Dilepton events

- $N_I = N_{pp} + N_{fp} + N_{ff} = N_{t11} + N_{t10} + N_{t01} + N_{t00}$
- $N_{t00} = (1 - p_1)(1 - p_2)N_{pp} + (1 - p_1)(1 - f_2)N_{pf} + (1 - f_1)(1 - p_2)N_{fp} + (1 - f_1)(1 - f_2)N_{ff}$
- $N_{t10} = p_1(1 - p_2)N_{pp} + p_1(1 - f_2)N_{pf} + f_1(1 - p_2)N_{fp} + f_1(1 - f_2)N_{ff}$
- $N_{t01} = (1 - p_1)p_2N_{pp} + (1 - p_1)f_2N_{pf} + (1 - f_1)p_2N_{fp} + (1 - f_1)f_2N_{ff}$
- $N_{t11} = p_1p_2N_{pp} + p_1f_2N_{pf} + f_1p_2N_{fp} + f_1f_2N_{ff}$

## Event selection (SUSY)

- Triggers: lepton triggers
- Cleaning cuts - No of good vertex  $> 0$
- HBHE noise filter
- Pure tracks
- No of good leptons  $> 1$  ( $ee$ ,  $e\mu$ ,  $\mu\mu$ )
- No of good leptons  $= 2$  ( $ee$ ,  $e\mu$ ,  $\mu\mu$ )
- Is same-sign ( $ee$ ,  $e\mu$ ,  $\mu\mu$ )
- $M_{inv}(SS \text{ II}) > 5 \text{ GeV}$
- SSPrimary vertex  $Z < 1 \text{ cm}$
- $|M_{inv}(OS \text{ II}) - MZ| > 15 \text{ GeV}$
- No of Jets  $> 1$
- $H_T(\text{particle flow}) > 250 \text{ GeV}$
- MET (particle flow)  $> 100 \text{ GeV}$
- $R_{\text{ellso1}} < 0.15$
- $R_{\text{ellso2}} < 0.15$

## Muon selection

- $p_T > 10$  GeV
- $|\eta| < 2.4$
- Reduced  $\chi^2 < 10$
- Is Global and Tracker muon
- NoOfTrackerHits  $> 10$
- No of valid silicon Hits  $> 10$
- $|d0_{corr}| < 0.02$  (z-distance with respect to beam spot)
- Valid Stand Alone Hits  $> 0$
- ecalvetoDep  $< 4$  GeV
- hcalvetoDep  $< 6$  GeV

### Loose:

Relative Isolation  $< 1.0$  (cone R = 0.3)

### Tight:

Relative Isolation  $< 0.15$  (cone R = 0.3)

## Electron selection

- $p_T > 20$  GeV
- $|\eta| < 2.4$
- Exclude  $\eta$ -gap ( $1.47 < |\eta| < 1.57$ )
- $|d0_{corr}| < 0.02$  (z-distance with respect to beam spot)
- No  $\mu$  within  $\Delta R < 0.1$
- Conversion rejection (from 80% eff working point)
- ECAL driven seed
- Charge(GSF) = Charge(CTF) = Charge(ScPix)

Loose  $Rellso < 1.0 / 0.6$  (Barrel/ Endcap) VBTF-IDc 90 == 5 || 7

Tight  $Rellso < 0.15$  VBTF-IDc 80 == 5 || 7

# Jet selection

- $p_T > 30\text{GeV}$
- $|\eta| < 2.5$
- Ak5Jets: loose ID (L2 & L3; PF)
- $\Delta R$  to electrons  $> 0.4$
- $\Delta R$  to muons  $> 0.4$